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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/605,699	10/21/2003	Kiran V. Chatty	BUR920030120US1	2698
30678	7590	06/14/2005	EXAMINER	
CONNOLLY BOVE LODGE & HUTZ LLP SUITE 800 1990 M STREET NW WASHINGTON, DC 20036-3425			VU, DAVID	
			ART UNIT	PAPER NUMBER
			2818	

DATE MAILED: 06/14/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

AK

Office Action Summary	Application No.	Applicant(s)	
	10/605,699	CHATTY ET AL.	
	Examiner	Art Unit	
	DAVID VU	2818	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 22 April 2005.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-51 is/are pending in the application.
- 4a) Of the above claim(s) 32-51 is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-31 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☒ Claim(s) 1-51 are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 21 October 2003 is/are: a) ☐ accepted or b) ☒ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input checked="" type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date <u>10/21/03; 12/24/03 & 08/10/04</u> | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Election/Restrictions

1. Applicant's election without traverse of Group I (Claims 1-31) on 04/22/2005 is acknowledged.

Claims 32-51 are withdrawn from further consideration pursuant to 37 CFR 1.142(b) as being drawn to a nonelected invention, there being no allowable generic or linking claim.

Election was made **without** traverse in the reply filed on 04/22/2005.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

2. Claims 1-10 and 15-31 are rejected under 35 U. S. C. 102(b) as being anticipated by Kim et al. (US Pat. 5,675,170).

Regarding claims 1 and 22, Kim discloses, in figs. 3 and 4, a method of forming a semiconductor structure having improved latch-up robustness, the method comprising the steps of: providing a substrate 1 including an injection site (I/O) and a plurality of circuit structures (NMOS/PMOS), wherein at least one of circuit structures has a susceptibility to a latch-up

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condition (col. 3, lines 8-16); and forming a plurality of contact regions (22/23/41/32/33/2/3/4) inter-spaced a varying distance between circuit structures.

Regarding claims 2, 3, 23 and 24, Kim discloses the distance varies with the proximity of contact regions to injection site; wherein distance varies with the susceptibility of circuit structures to a latch-up condition (figs. 3-4 and col. 3, lines 8-16).

Regarding claims 4-6 and 25-27, Kim discloses the plurality of contact regions comprises a first contact region 22 and a second contact region 23 spaced a first distance apart, and second contact region 23 and a third contact region 41 spaced a second distance apart different from first distance (figs. 3-4).

Regarding claim 7, Kim discloses the substrate comprises a well region having formed therein latch-up susceptible circuit structure (figs. 3-4).

Regarding claim 8, Kim discloses the well region (3/4) is n-type (figs. 3-4).

Regarding claim 9, Kim discloses the n-type well region (3/4) includes at least one contact comprising an n+ region (41/34) (figs. 3-4).

Regarding claim 10, Kim discloses at least one contact is coupled to Vdd (figs. 3-4).

Regarding claim 15, Kim discloses the plurality of contact regions are located along an axis and arranged vertically relative to axis (fig. 3).

Regarding claim 16, Kim discloses the plurality of contact regions are located along an axis and arranged horizontally relative to axis (fig. 3).

Regarding claim 17, Kim discloses the plurality of contact regions are located along an axis and arranged concentrically relative to axis (fig. 3).

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Regarding claims 20 and 30, Kim discloses the distance increases as the distance of plurality of contact regions from injection site increases (figs. 3 and 4).

Regarding claims 21 and 31, Kim discloses the plurality of contact regions are located along an axis so that spacing between adjacent contact regions increases as the distance from injection site increases (figs. 3 and 4).

Regarding claims 18, 19, 28 and 29, the limitations " wherein said distance is determined such that" (claims 18 and 28) or " wherein said external current injector is a cable discharge" (claims 19 and 29) are merely functional/intended use limitations that do not structurally distinguish the claimed invention over the prior. A recitation of the intended use of the claimed invention must result in a structural difference between the claimed invention and the prior art in order to patentably distinguish the claimed invention from the prior art. If the prior art structure is capable of performing the intended use, then it meets the claim. See *In re Casey*, 370 F.2d 576, 152 USPQ 235 (CCPA 1967) and *In re Otto*, 312 F.2d 937, 939, 136 USPQ 458, 459 (CCPA 1963).

3. Claims 1, 7 and 11-14 are rejected under 35 U. S. C. 102(b) as being anticipated by Magee (US Pat. 4,642,667).

Regarding claim 1, Magee discloses, in figs. 1 and 2, a method of forming a semiconductor structure having improved latch-up robustness, the method comprising the steps of: providing a substrate 11 including an injection site (I/O) and a plurality of circuit structures (CMOS), wherein at least one of circuit structures has a susceptibility to a latch-up condition

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(col. 1, line 62 through col. 2, line 53); and forming a plurality of contact regions (32/33/34/35/36) inter-spaced a varying distance between circuit structures.

Regarding claims 7 and 11, Magee discloses, in figs. 1 and 2, substrate comprises a p-well region having formed therein latch-up susceptible circuit structure.

Regarding claim 12, Magee discloses, in figs. 1 and 2, a p-type well region includes at least one contact comprising a p⁺ region.

Regarding claim 13, Magee discloses, in figs. 1 and 2, at least one contact is coupled to ground.

Regarding claim 14, Magee discloses, in figs. 1 and 2, at least one contact is coupled to V_{ss}.

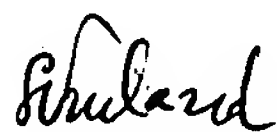
Conclusion

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to David Vu whose telephone number is (571) 272-1798. The examiner can normally be reached on Monday-Friday from 8:00am to 5:00pm. If attempt to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Nelms can be reached on (571) 272-1787. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR, Status information for unpublished

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applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).



David Vu

May 26, 2005.